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Surface chemical analysis - X-ray photoelectron spectrometers - Calibration of energy scales (ISO 15472:2010); Text in English

Contents		Page
Foreword		iv
Introduction.....		v
1 Scope		1
2 Normative references		1
3 Symbols and abbreviated terms		1
4 Outline of method.....		2
5 Procedure for calibrating the energy scale		5
5.1 Obtaining the reference samples.....		5
5.2 Mounting the samples.....		6
5.3 Cleaning the samples.....		6
5.4 Choosing the spectrometer settings for which energy calibration is required.....		6
5.5 Operating the instrument.....		6
5.6 Options for initial or subsequent calibration measurements		7
5.7 Measurements for the peak binding-energy repeatability standard deviation and the scale linearity		7
5.8 Calculating the peak binding-energy repeatability standard deviation		8
5.9 Checking the binding-energy scale linearity		11
5.10 Procedure for the regular determination of the calibration error.....		12
5.11 Procedures for correction of the instrument binding-energy scale		13
5.12 Next calibration.....		15
5.13 Establishing the calibration interval.....		15
Annex A (normative) Least-squares determination of the peak binding energy by a simple computational method		16
Annex B (informative) Derivation of uncertainties		19
Annex C (informative) Citation of the uncertainties of measured binding energies.....		21
Annex D (informative) Measurements of modified Auger parameters measured using XPS instruments equipped with a monochromated Al X-ray source.....		23
Bibliography		26